

<b>Notice of References Cited</b>	Application/Control No. 10/064,965	Applicant(s)/Patent Under Reexamination SKUFGA ET AL.	
	Examiner Apu M Mofiz	Art Unit 2165	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,757,708	06-2004	Craig et al.	709/203
	B	US-2002/0152422	10-2002	Sharma et al.	714/13
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Scott W. Ambler, Overcoming data design challenges, August 2001, pages 1-3
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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